

| Title: | Performance report for SiT9365, 155.52 MHz, HCSL |       |                |
|--------|--|-------|----------------|
| Type:  | Performance report                               | Rev:  | 1.0            |
| Orig:  |  | Date: | April 16, 2018 |

### Performance report for SiT9365 - 155.52 MHz, HCSL

#### **Conditions:**

- Frequency 155.52 MHz

- VDD: 2.5 V, 3.3 V

- Room temperature

- Termination:

 $\circ$  30 Ω series and 50 Ω to GND.

# **Equipment:**

| Model                                    | Measurement / Purpose                                |
|--|--|
| Keysight DSA90604A (6 GHz,               | Period jitter, differential voltage swing, rise/fall |
| 20 Gsps)                                 | time, duty cycle                                     |
| Keysight 5052B Signal Source<br>Analyzer | Phase noise, integrated phase jitter                 |
| Keysight 34980A                          | Power supply current                                 |
| Keysight E3631A                          | Power supply   |
| Keysight 53230A                          | Frequency  |

# Test setup:

For waveform parameters measurement (rise/fall time, differential swing, duty cycle), both DUT outputs are terminated with 30  $\Omega$  series and 50  $\Omega$  to GND. Output signals are measured using Keysight 1134B active probe with Keysight N5425B probe head. All measurements are applied to the differential waveform. Figure 1 shows test setup diagram for waveform parameters measurement.

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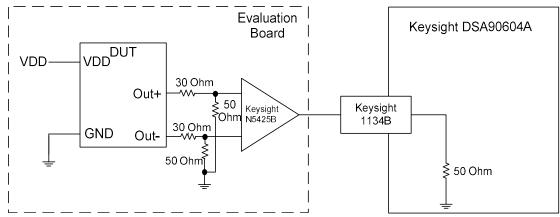


Figure 1: Test setup for measuring waveform parameters (rise/fall time, differential swing, duty cycle)

For period jitter measurement output is terminated with 30  $\Omega$  series and 50  $\Omega$  to GND at the input of hi-speed comparator (ADCMP581). AC coupled comparator's output is connected to oscilloscope channel. Figure 2 shows test setup diagram for period jitter measurement.

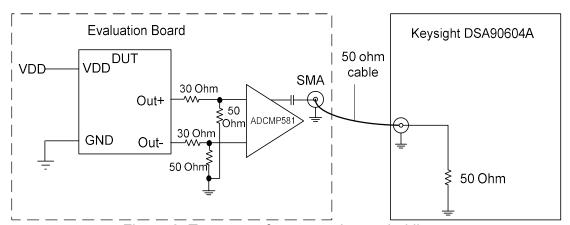
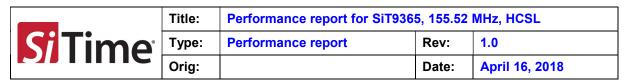


Figure 2: Test setup for measuring period jitter

For phase noise measurements, differential signal is converted to single-ended using impedance matching transformer. Transformer's output is connected to measurement instrument. Output is also terminated with 30  $\Omega$  series at the source side. Figure 3 shows test setup diagram for phase noise measurement.



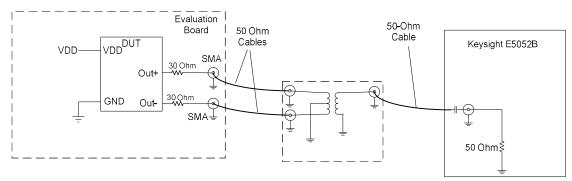


Figure 3: Test setup for measuring phase noise.

For IDD measurement device output is floating. For frequency measurement differential-to-single-ended converter is used.

#### Data:

- Phase noise
- Integrated phase jitter
- RMS period jitter
- Peak-to-peak period jitter
- Rise/fall time
- Duty cycle
- Differential output swing
- IDE
- Frequency stability over temperature

Table 1: Summary performance data

| Parameter                                      | Units     | Voltage |       |
|--|-----------|---------|-------|
| Falametel                                      | UTILIS    | 2.5 V   | 3.3 V |
| Integrated Phase jitter (1.875 MHz - 20 MHz)   | fs, rms   | 94      | 94    |
| Integrated Phase jitter (12 kHz - 20 MHz)      | fs, rms   | 222     | 220   |
| Period jitter                                  | ps, rms   | 0.99    | 0.99  |
| Period jitter (10,000 cycles)                  | ps, pk-pk | 7.69    | 7.63  |
| Duty cycle                                     | %         | 50.0    | 50.0  |
| Rise time (20% - 80%)                          | ps        | 377     | 374   |
| Fall time (80% - 20%)                          | ps        | 386     | 383   |
| Differential voltage swing                     | V         | 1.45    | 1.52  |
| Current consumption (no load, output enabled)  | mA        | 77.1    | 77.8  |
| Current consumption (no load, output disabled) | mA        | 50.9    | 51.2  |

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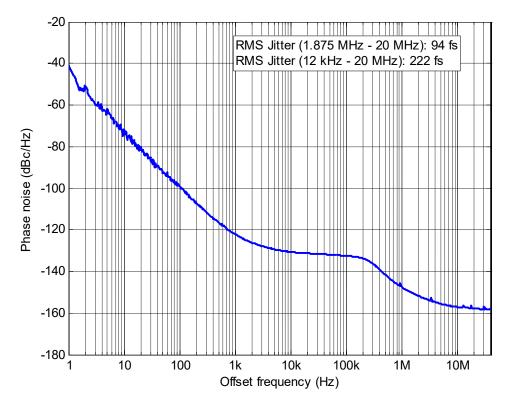


Figure 4: Phase noise, 2.5 V



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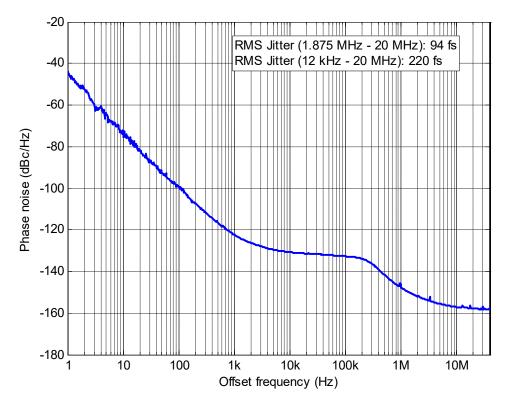


Figure 5: Phase noise, 3.3 V

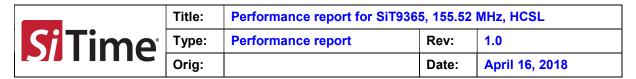




Figure 6: Output waveform, 2.5 V

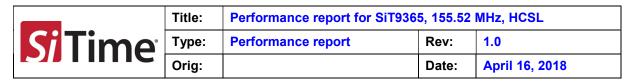




Figure 7: Output waveform, 3.3 V



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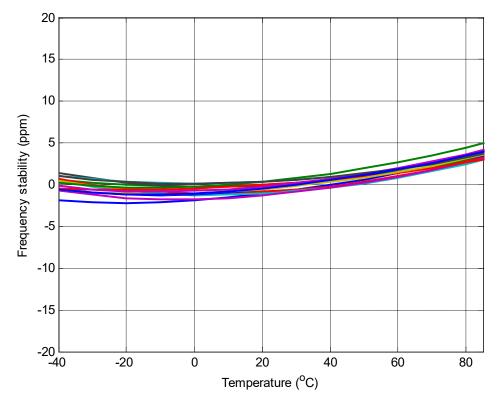


Figure 8: Frequency stability\* over temperature, 2.5 V

\*SiT9365 frequency stability is independent of output frequency.



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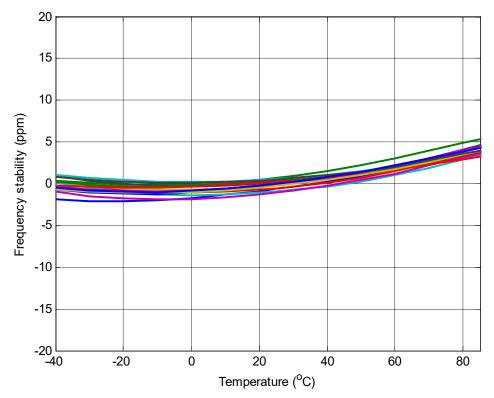


Figure 9: Frequency stability over temperature, 3.3 V